

<b>Notice of References Cited</b>	Application/Control No. 10/697,589	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Howard Weiss	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,707,098	03-2004	Hofmann et al.	257/324
	B	US-6,515,339	02-2003	Shin et al.	257/368
	C	US-6,286,226	09-2001	Jin	33/706
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04-097564	03-1992	JPX	Yano et al.	257/25
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.